Docket No.: 020732-110.694 Appl. No.: 10/807,858

## Section I. (Amendment to the Claims)

1. (Withdrawn) A bottom anti-reflection coating (BARC) removal composition, comprising at least one SCF, at least one co-solvent, at least one etchant and at least one surfactant.

- 2. (Withdrawn) The BARC removal composition of claim 1, wherein the SCF comprises a fluid selected from the group consisting of carbon dioxide, oxygen, argon, krypton, xenon, and ammonia.
- 3. (Withdrawn) The BARC removal composition of claim 1, wherein the SCF comprises carbon dioxide.
- 4. (Withdrawn) The BARC removal composition of claim 1, wherein the co-solvent comprises at least one C<sub>1</sub>-C<sub>6</sub> alkanol.
- 5. (Withdrawn) The BARC removal composition of claim 1, wherein the co-solvent comprises isopropanol.
- 6. (Withdrawn) The BARC removal composition of claim 1, wherein the co-solvent comprises an amine selected from the group consisting of monoethanolamine, triethanolamine, triethylenediamine, methyldiethanolamine, pentamethyldiethylenetriamine, diglycolamine, N-methylpyrrolidone (NMP), N-octylpyrrolidone, N-phenylpyrrolidone and vinyl pyrrolidone.
- 7. (Withdrawn) The BARC removal composition of claim 1, wherein the etchant comprises at least one of HF, ammonium fluoride, triethylamine trihydrofluoride, hydrogen peroxide, acetic acid, nitric acid and sulfuric acid.

Docket No.: 020732-110.694 Appl. No.: 10/807,858

8. (Withdrawn) The BARC removal composition of claim 1, wherein the etchant comprises triethylamine trihydrofluoride.

- 9. (Withdrawn) The BARC removal composition of claim 1, wherein the surfactant comprises at least one nonionic surfactant or at least one anionic surfactant.
- (Withdrawn) The BARC removal composition of claim 9, wherein the nonionic 10. surfactant comprises at least one species selected from the group consisting of fluoroalkyl surfactants, ethoxylated fluorosurfactants, polyethylene glycols, polypropylene glycols, polyethylene polypropylene glycol ethers, carboxylic salts, ethers, dodecylbenzenesulfonic acid, dodecylbenzenesulfonic salts, polyacrylate polymers, dinonylphenyl polyoxyethylene, silicone polymers, modified silicone polymers, acetylenic diols, modified acetylenic diols, alkylammonium salts, alkylammonium salts.
- 11. (Withdrawn) The BARC removal composition of claim 9, wherein the surfactant comprises an ethoxylated fluorosurfactant.
- 12. (Withdrawn) The BARC removal composition of claim 9, wherein the anionic surfactant comprises at least one species selected from the group consisting of fluorosurfactants, sodium alkyl sulfates, ammonium alkyl sulfates, C<sub>10</sub>-C<sub>18</sub> alkyl carboxylic acid ammonium salts, sodium sulfosuccinates and esters thereof, and C<sub>10</sub>-C<sub>18</sub> alkyl sulfonic acid sodium salts.
- 13. (Withdrawn) The BARC removal composition of claim 1, wherein the SCF-based removal composition comprises about 60.0 wt % to about 90.0 wt % SCF, about 10.0 wt

Docket No.: 020732-110.694

Appl. No.: 10/807,858

% to about 30.0 wt % co-solvent, about 0.01 wt % to about 5.0 wt % etchant, and about

0.01 wt % to about 5.0 wt % surfactant, based on the total weight of the composition.

14. (Withdrawn) A bottom anti-reflection coating (BARC) removal composition, comprising

supercritical carbon dioxide (SCCO<sub>2</sub>), triethylamine trihydrofluoride, a fluorosurfactant

and isopropyl alcohol.

15. (Currently Amended) A method of removing a bottom anti-reflection coating (BARC)

layer from a substrate having same thereon, said method comprising contacting the

substrate having the BARC layer thereon with an SCF-based removal composition

eomprising consisting essentially of at least one SCF, at least one co-solvent, at least one

etchant, and at least one surfactant, for sufficient time and under sufficient contacting

conditions to substantially at least partially remove the BARC layer from the substrate,

wherein the contacting conditions comprise temperature in a range of from about 50°C to

about 90°C.

16. (Original) The method of claim 15, wherein the SCF comprises a fluid selected from the

group consisting of carbon dioxide, oxygen, argon, krypton, xenon, and ammonia.

17. (Original) The method of claim 15, wherein the SCF comprises carbon dioxide.

18. (Currently Amended) The method of claim 15, wherein the contacting conditions

comprise pressure in a range of from about 1500 psi to about 4500 psi and temperature in

a range of from about 50°C to about 90°C.

19. (Original) The method of claim 15, wherein said contacting time is in a range of from

about 1 minutes to about 20 minutes.

5

Docket No.: 020732-110.694 Appl. No.: 10/807,858

20. (Original) The method of claim 15, wherein the co-solvent comprises at least one C<sub>1</sub>-C<sub>6</sub> alkanol.

- 21. (Original) The method of claim 15, wherein the co-solvent comprises isopropanol (IPA).
- 22. (Original) The method of claim 15, wherein the co-solvent comprises an amine selected from the group consisting of monoethanolamine, triethanolamine, triethylenediamine, methyldiethanolamine, pentamethyldiethylenetriamine, diglycolamine, N-methylpyrrolidone (NMP), N-octylpyrrolidone, N-phenylpyrrolidone and vinyl pyrrolidone.
- 23. (Currently Amended) The method of claim 15, wherein the etchant comprises at least one of HF, ammonium fluoride, triethylamine trihydrofluoride, hydrogen peroxide, acetic acid, nitric acid and sulfuric acid.
- 24. (Original) The method of claim 15, wherein the etchant comprises triethylamine trihydrofluoride.
- 25. (Original) The method of claim 15, wherein the surfactant comprises at least one nonionic surfactant or at least one anionic surfactant.
- 26. (Original) The method of claim 25, wherein the surfactant comprises at least one species selected from the group consisting of fluoroalkyl surfactants, ethoxylated fluorosurfactants, polyethylene glycols, polypropylene glycols, polyethylene ethers, polypropylene glycol ethers, carboxylic acid salts, dodecylbenzenesulfonic acid, dodecylbenzenesulfonic salts, polyacrylate polymers, dinonylphenyl polyoxyethylene, silicone polymers, modified silicone polymers, acetylenic diols, modified acetylenic

Docket No.: 020732-110.694

Appl. No.: 10/807,858

diols, alkylammonium salts, modified alkylammonium salts, and combinations

comprising at least one of the foregoing.

27. (Original) The method of claim 25, wherein the anionic surfactant comprises at least one

species selected from the group consisting of fluorosurfactants, sodium alkyl sulfates,

ammonium alkyl sulfates, C<sub>10</sub>-C<sub>18</sub> alkyl carboxylic acid ammonium salts, sodium

sulfosuccinates and esters thereof, and C<sub>10</sub>-C<sub>18</sub> alkyl sulfonic acid sodium salts.

28. (Previously Presented) The method of claim 15, wherein the SCF-based removal

composition further comprises BARC material residue.

29. (Previously Presented) The method of claim 28, wherein the BARC material comprises a

species selected from the group consisting of polysulfones, polyureas, polyureas sulfones,

polyacrylates, and poly(vinyl pyridine).

30. (Previously Presented) The method of claim 15, wherein the SCF-based removal

composition further comprises photoresist material residue.

31. (Original) The method of claim 15, wherein the contacting step comprises a cycle

including (i) dynamic flow contacting of the SCF-based removal composition with the

substrate having the BARC layer thereon, and (ii) static soaking contacting of the SCF-

based removal composition with the substrate having the BARC layer thereon.

32. (Original) The method of claim 31, wherein said cycle comprises alternatingly and

repetitively carrying out dynamic flow contacting (i) and static soaking contacting (ii) of

the substrate having the BARC layer thereon.

7

Docket No.: 020732-110.694

Appl. No.: 10/807,858

33. (Previously Presented) The method of claim 15, further comprising washing the substrate

with a first washing composition at a region at which the BARC layer has been removed

to remove residual precipitated chemical additives.

34. (Previously Presented) The method of claim 33, wherein the first washing composition

includes a SCF, methanol and deionized water.

35. (Currently Amended) The method of claim 15, wherein the etchant comprises at least one

of hydrogen peroxide, acids, fluoride ion source compounds, or a combination thereof.

36. (Currently Amended) A method of removing an ion implanted photoresist layer and a

bottom anti-reflection coating (BARC) layer from a substrate having same thereon, said

method comprising contacting the substrate having the photoresist layer and the BARC

layer thereon with a SCF-based removal composition consisting essentially of comprising

at least one SCF, at least one co-solvent, at least one etchant, at least one implanted ion,

and at least one surfactant, for sufficient time and under sufficient contacting conditions

to at least partially remove the ion-implanted photoresist layer and the BARC layer from

the substrate, wherein the contacting conditions comprise temperature in a range of from

about 50°C to about 90°C.

37. (Previously Presented) The method of claim 15, wherein the co-solvent comprises at least

one amine.

8